



MEASUREMENT REPORT FCC Part 27 / IC RSS-199 LTE

Applicant Name:

Samsung Electronics, Co. Ltd.
129, Samsung-ro, Maetan dong,
Yeongtong-gu, Suwon-si
Gyeonggi-do 443-742, Korea

Date of Testing:

12/20 -1/15/2014

Test Site/Location:

PCTEST Lab., Columbia, MD, USA

Test Report Serial No.:

0Y1312312541.A3L

FCC ID :
A3LGTI9507V
APPLICANT:
SAMSUNG ELECTRONICS, CO. LTD.
FCC Classification:

PCS Licensed Transmitter Held to Ear (PCE)

FCC Rule Part(s):

§2; §27

EUT Type:

Portable Handset

Model(s):

GT-I9507V

Test Device Serial No.:

identical prototype [S/N: FK 390 A, FK 390 B]

Mode	Tx Frequency (MHz)	Emission Designator	Modulation	ERP/EIRP	
				Max. Power (W)	Max. Power (dBm)
LTE Band 41	2501 - 2685	8M98G7D	QPSK	0.066	18.18
LTE Band 41	2501 - 2685	8M93W7D	16QAM	0.049	16.94
LTE Band 41	2503.5 - 2682.5	13M5G7D	QPSK	0.051	17.03
LTE Band 41	2503.5 - 2682.5	13M5W7D	16QAM	0.042	16.27
LTE Band 41	2506 - 2680	18M0G7D	QPSK	0.042	16.25
LTE Band 41	2506 - 2680	17M9W7D	16QAM	0.033	15.15

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested. I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.


Randy Ortanez
President

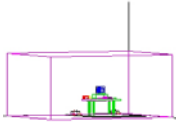


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MEASUREMENT REPORT

FCC Part 27

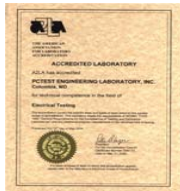


§2.1033 General Information

APPLICANT: Samsung Electronics, Co. Ltd.
APPLICANT ADDRESS: 129, Samsung-ro, Maetan dong,
 Yeongtong-gu, Suwon-si, Gyeonggi-do 443-742, Korea
TEST SITE: PCTEST ENGINEERING LABORATORY, INC.
TEST SITE ADDRESS: 6660-B Dobbin Road, Columbia, MD 21045 USA
FCC RULE PART(S): §2; §27
BASE MODEL: GT-I9507V
FCC ID: A3LGTI9507V
FCC CLASSIFICATION: PCS Licensed Transmitter Held to Ear (PCE)
FREQUENCY TOLERANCE: $\pm 0.00025\%$ (2.5 ppm)
Test Device Serial No.: FK 390 A, FK 390 B ☐ Production ☒ Pre-Production ☐ Engineering
DATE(S) OF TEST: 12/20 -1/15/2014
TEST REPORT S/N: 0Y1312312541.A3L

Test Facility / Accreditations

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21046, U.S.A.



- PCTEST facility is an FCC registered (PCTEST Reg. No. 90864) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (2451A-1).
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing Aid Compatibility (HAC) testing, CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (2451A-1) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS, CDMA, and EvDO wireless devices and for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO, and CDMA 1xRTT.

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1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EME) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

1.2 Testing Facility

The map below shows the location of the PCTEST LABORATORY, its proximity to the FCC Laboratory, the Columbia vicinity, the Baltimore-Washington Intern't'l (BWI) airport, the city of Baltimore and the Washington, DC area. (See Figure 1-1).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility in New Concept Business Park, Guilford Industrial Park, Columbia, Maryland. The site address is 6660-B Dobbin Road, Columbia, MD 21045. The test site is one of the highest points in the Columbia area with an elevation of 390 feet above mean sea level. The site coordinates are 39° 11'15" N latitude and 76° 49'38" W longitude. The facility is 1.5 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. There are no FM or TV transmitters within 15 miles of the site. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2009 on January 10, 2012.

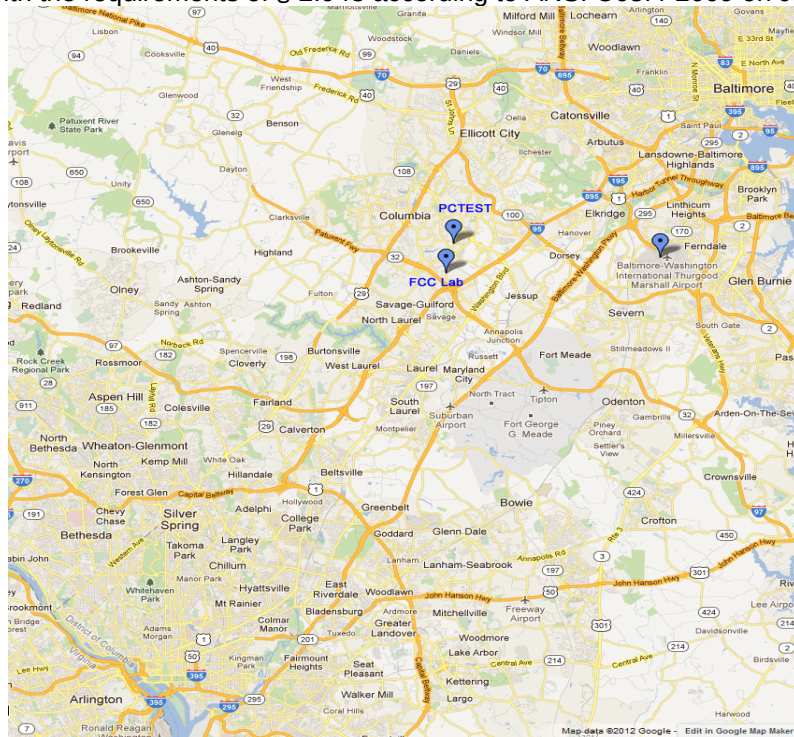


Figure 1-1. Map of the Greater Baltimore and Metropolitan Washington, D.C. area

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2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LGTI9507V**. The test data contained in this report pertains only to the emissions due to the EUT's LTE function.

2.2 Device Capabilities

This device contains the following capabilities:

850/1900 GSM/GPRS/EDGE, 850/1900 WCDMA/HSPA, Band 41 (10, 15, and 20 MHz BW) LTE, 802.11a/b/g/n/ac WLAN (DTS/NII), Bluetooth (1x, EDR, LE), NFC

2.3 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

2.4 Labeling Requirements

Per 2.925

The FCC identifier shall be permanently affixed to the equipment and shall be readily visible to the purchaser at the time of purchase.

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3.0 DESCRIPTION OF TESTS

3.1 Measurement Procedure

The measurement procedures described in the document titled “Land Mobile FM or PM – Communications Equipment – Measurements and Performance Standards” (ANSI/TIA-603-C-2004) and “Procedures for Compliance Measurement of the Fundamental Emission Power of Licensed Wideband (> 1 MHz) Digital Transmission Systems” (KDB 971168) were used in the measurement of the **Samsung Portable Handset FCC ID: A3LGTI9507V**.

3.2 Occupied Bandwidth

§2.1049

The implementation of this test is performed by the spectrum analyzer's occupied bandwidth function. The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured.

3.3 Spurious and Harmonic Emissions at Antenna Terminal

§2.1051 §27.53(m)

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least $43 + 10 \log(P)$ dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 100 kHz or greater for or 1 MHz or greater for BRS and EBS stations. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed for BRS and EBS stations. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

3.4 Peak-Average Ratio

A peak to average ratio measurement is performed at the conducted port of the EUT. For LTE signals, the spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth. The CCDF curve shows how much time the peak waveform spends at or above a given average power level. The percent of time the signal spends at or above the level defines the probability for that particular power level.

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3.5 Radiated Power and Radiated Spurious Emissions

§2.1053 §27.50(c.10) §27.53(h)

Radiated spurious emissions are investigated indoors in a semi-anechoic chamber to determine the frequencies producing the worst case emissions. Final measurements for radiated power and radiated spurious emissions are performed on the 3 meter OATS per the guidelines of ANSI/TIA-603-C-2004. The measurement area is situated on an 18 meter x 20 meter galvanized 1/2" hardware cloth as the conducting ground plane. This material is sewn together in sections 4 feet wide and 60 feet long. A total of eighteen sections are required to cover the entire measurement area. Sections are laid across the width of the pad, overlapped 1" and sewn and soldered together at intervals of 3" (7.6 cm.) The terrain of the test site is reasonably flat and level. Power and cable to the test site are buried 18" deep into the ground outside the perimeter of the site. An all-weather non-metallic housing is situated on a 2 x 3 meter area adjacent to the measurement area to house the test equipment. The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 80cm above the ground plane and 3 meters from the receive antenna. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Emissions are also investigated with the receive antenna horizontally and vertically polarized. The level of the maximized emission is recorded with the spectrum analyzer using a peak detector with RBW = 1MHz, VBW = 3MHz for emissions greater than 1GHz. For emissions below 1GHz, the spectrum analyzer is set to RBW = 100kHz and VBW = 300kHz.

A half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

$$P_d \text{ [dBm]} = P_g \text{ [dBm]} - \text{cable loss [dB]} + \text{antenna gain [dBd/dBi]}$$

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to $P_g \text{ [dBm]} - \text{cable loss [dB]}$.

The calculated P_d levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of $43 + 10\log_{10}(\text{Power [Watts]})$ specified in 22.917(a), 24.238(a), and 27.53(h).

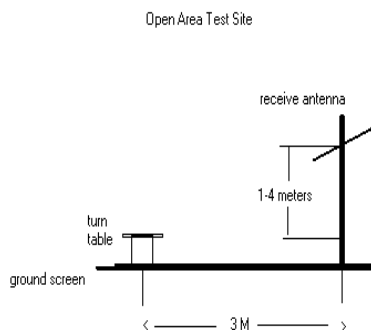


Figure 3-1. Diagram of 3-meter Test Range

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3.6 Frequency Stability / Temperature Variation

§2.1055 §27.5(c) §27.5(i) §27.54

The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block for Part 27.

Time Period and Procedure:

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a “standby” condition for one minute before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A sufficient stabilization period at each temperature shall be used prior to each frequency requirement.

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4.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST).

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	RE1	Radiated Emissions Cable Set (UHF/EHF)	3/29/2013	Annual	3/29/2014	N/A
-	RE2	Radiated Emissions Cable Set (VHF/UHF)	3/29/2013	Annual	3/29/2014	N/A
-	LTx2	Licensed Transmitter Cable Set	1/17/2013	Annual	1/17/2014	N/A
Agilent	8449B	(1-26.5GHz) Pre-Amplifier	4/17/2013	Annual	4/17/2014	3008A00985
Agilent	8648D	(9kHz-4GHz) Signal Generator	10/28/2013	Annual	10/28/2014	3613A00315
Agilent	N9020A	MXA Signal Analyzer	10/29/2013	Annual	10/29/2014	US46470561
Agilent	N9030A	PXA Signal Analyzer (44GHz)	1/11/2013	Annual	1/11/2014	MY52350166
Agilent	8447D	Broadband Amplifier	5/31/2013	Annual	5/31/2014	1937A03348
Anritsu	MA2411B	Pulse Sensor	11/13/2013	Annual	11/13/2014	846215
Anritsu	ML2495A	Power Meter	10/31/2013	Annual	10/31/2014	1039008
Emco	6502	Active Loop Antenna (10k - 30 MHz)	5/31/2012	Biennial	5/31/2014	267
Mini-Circuits	VHF-1300+	High Pass Filter	1/21/2013	Annual	1/21/2014	30716
Mini-Circuits	VHF-3100+	High Pass Filter	1/21/2013	Annual	1/21/2014	31144
Rohde & Schwarz	CMW500	LTE Radio Communication Tester	N/A		N/A	81059
Schwarzbeck	UHA 9105	Dipole Antenna (400 - 1GHz) Tx	11/1/2013	Biennial	11/1/2015	91052522TX
Schwarzbeck	UHA 9105	Dipole Antenna (400 - 1GHz) Rx	11/1/2013	Biennial	11/1/2015	91052523RX
Schwarzbeck	VULB-9161SE	Trilog Super Broadband Test Antenna	10/23/2013	Biennial	10/23/2015	9161-4075
Seekonk	NC-100	Torque Wrench (8" lb)	3/5/2012	Triennial	3/5/2015	N/A
Sunol	DRH-118	Horn Antenna (1 - 18GHz)	6/19/2013	Biennial	6/19/2015	A050307
Sunol	DRH-118	Horn Antenna (1-18 GHz)	6/19/2013	Biennial	6/19/2015	A042511

Table 4-1. Test Equipment

Notes:

1. For equipment listed above that has a calibration due date that falls within the test date range, care was taken to ensure that this equipment was utilized prior to the calibration due date.
2. Equipment used for signaling with a calibration date of "N/A" shown in this list was only used for maintaining a link between the piece of equipment and the EUT. This equipment was not used to make direct calibrated measurements.

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5.0 SAMPLE CALCULATIONS

Emission Designator

QPSK Modulation

Emission Designator = 8M62G7D

LTE BW = 8.62 MHz

G = Phase Modulation

7 = Quantized/Digital Info

D = Amplitude/Angle Modulated

16QAM Modulation

Emission Designator = 8M45W7D

LTE BW = 8.45 MHz

W = Amplitude/Angle Modulated

7 = Quantized/Digital Info

D = Combination (Audio/Data)

Spurious Radiated Emission – LTE Band

Example: Middle Channel LTE Mode 2nd Harmonic (1564 MHz)

The average spectrum analyzer reading at 3 meters with the EUT on the turntable was –81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of –81.0 dBm on the spectrum analyzer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 1564 MHz. So 6.1 dB is added to the signal generator reading of –30.9 dBm yielding –24.80 dBm. The fundamental EIRP was 25.501 dBm so this harmonic was 25.501 dBm – (-24.80).

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6.0 TEST RESULTS

6.1 Summary

Company Name: Samsung Electronics, Co. Ltd.
 FCC ID: A3LGTI9507V
 FCC Classification: PCS Licensed Transmitter Held to Ear (PCE)
 Mode(s): LTE

FCC Part Section(s)	Test Description	Test Limit	Test Condition	Result	Reference
TRANSMITTER MODE (TX)					
2.1049	Occupied Bandwidth	N/A	CONDUCTED	PASS	Section, 7.0
2.1051 27.53(m)	Band Edge / Conducted Spurious Emissions	$> 43 + 10\log_{10}(P[\text{Watts}])$ at Band Edge and for all out-of-band emissions		PASS	Section, 7.0
	Peak-Average Ratio	< 13 dB		PASS	Section
2.1046	Transmitter Conducted Output Power	N/A		PASS	See RF Exposure Report
27.50(h.2)	Equivalent Isotropic Radiated Power (Band EBS)	< 2 Watts max. EIRP	RADIATED	PASS	Section 6.2
2.1053 27.53(m)	Undesirable Emissions	$> 43 + 10\log_{10}(P[\text{Watts}])$ for all out-of-band emissions		PASS	Section, 6.3
2.1055. 27.5(i) 27.54	Frequency Stability	Fundamental emissions stay within authorized frequency block (Part 27)		PASS	Section, 6.4

Table 6-1. Summary of Test Results

Notes:

- 1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
- 2) The analyzer plots shown in Section 7.0 were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
- 3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.

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6.2 Equivalent Isotropic Radiated Power (EIRP)

§27.50(h.2)

Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Battery	RB Size/Offset	Substitute Level [dBm]	Antenna Gain [dBi]	Pol [H/V]	EIRP [dBm]	EIRP [Watts]	Margin [dB]
2501.00	10	QPSK	Standard	1/49	5.21	8.94	H2	14.15	0.026	-18.86
2593.00	10	QPSK	Standard	1/49	9.09	9.09	H2	18.18	0.066	-14.83
2685.00	10	QPSK	Standard	1/0	5.74	9.65	H2	15.39	0.035	-17.62
2501.00	10	16-QAM	Standard	1/49	3.44	8.94	H2	12.38	0.017	-20.63
2593.00	10	16-QAM	Standard	1/49	7.85	9.09	H2	16.94	0.049	-16.07
2685.00	10	16-QAM	Standard	1/0	4.38	9.65	H2	14.03	0.025	-18.98
2503.50	15	QPSK	Standard	1/74	3.22	8.94	H2	12.16	0.016	-20.85
2593.00	15	QPSK	Standard	1/0	7.94	9.09	H2	17.03	0.051	-15.98
2682.50	15	QPSK	Standard	1/0	4.94	9.65	H2	14.59	0.029	-18.42
2503.50	15	16-QAM	Standard	1/74	2.16	8.94	H2	11.10	0.013	-21.91
2593.00	15	16-QAM	Standard	1/0	7.18	9.09	H2	16.27	0.042	-16.74
2682.50	15	16-QAM	Standard	1/0	3.98	9.65	H2	13.63	0.023	-19.38
2506.00	20	QPSK	Standard	1/99	3.62	8.94	H2	12.56	0.018	-20.45
2593.00	20	QPSK	Standard	1/0	5.84	9.09	H2	14.93	0.031	-18.08
2680.00	20	QPSK	Standard	1/99	6.60	9.65	H2	16.25	0.042	-16.76
2506.00	20	16-QAM	Standard	1/99	2.52	8.94	H2	11.46	0.014	-21.55
2593.00	20	16-QAM	Standard	1/0	4.70	9.09	H2	13.79	0.024	-19.22
2680.00	20	16-QAM	Standard	1/99	5.50	9.65	H2	15.15	0.033	-17.86

Table 6-2. EIRP Data (Band 41)

NOTES:

1. This device was tested under all bandwidths, and RB configurations, and modulations. This device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported in the table above.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The "H" positioning is defined with the EUT lying flat on the test surface, the "H2" positioning is defined with the EUT standing up on its side, and the "V" positioning is defined with the EUT standing upright. The worst case test configuration was found with the EUT in the H2 positioning. The data reported in the table above was measured in this test setup.

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6.3 Band 41 Radiated Spurious Emissions

§2.1053 §27.53(m)

Field Strength of SPURIOUS Radiation

OPERATING FREQUENCY: 2501.00 MHz
 MEASURED OUTPUT POWER: 14.15 dBm = 0.026 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 10 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 27.15 dBc

FREQUENCY (MHz)	LEVEL @ ANTENNA TERMINALS (dBm)	SUBSTITUTE ANTENNA GAIN (dBi)	SPURIOUS EMISSION LEVEL (dBm)	POL (H/V)	(dBc)
5002.00	-51.98	11.14	-40.84	H	54.99
7503.00	-48.40	10.98	-37.42	H	51.57
10004.00	-73.59	12.32	-61.27	H	75.42
12505.00	-53.87	13.08	-40.79	H	54.94

Table 6-3. Radiated Spurious Data

NOTES:

1. This device was tested under all bandwidths, and RB configurations, and modulations. This device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported in the table above.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The "H" positioning is defined with the EUT lying flat on the test surface, the "H2" positioning is defined with the EUT standing up on its side, and the "V" positioning is defined with the EUT standing upright. The worst case test configuration was found with the EUT in the H positioning. The data reported in the table above was measured in this test setup.

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Band 41 Radiated Spurious Measurements (continued)

§2.1053 §27.53(m)

Field Strength of SPURIOUS Radiation

OPERATING FREQUENCY: 2593.00 MHz
 MEASURED OUTPUT POWER: 18.18 dBm = 0.066 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 10 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10}(W) = 31.18$ dBc

FREQUENCY (MHz)	LEVEL @ ANTENNA TERMINALS (dBm)	SUBSTITUTE ANTENNA GAIN (dBi)	SPURIOUS EMISSION LEVEL (dBm)	POL (H/V)	(dBc)
5186.00	-39.75	11.02	-28.72	H	46.90
7779.00	-47.09	11.17	-35.91	H	54.10
10372.00	-73.05	12.40	-60.65	H	78.83
12965.00	-46.71	13.30	-33.41	H	51.59

Table 6-4. Radiated Spurious Data

NOTES:

1. This device was tested under all bandwidths, and RB configurations, and modulations. This device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported in the table above.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The "H" positioning is defined with the EUT lying flat on the test surface, the "H2" positioning is defined with the EUT standing up on its side, and the "V" positioning is defined with the EUT standing upright. The worst case test configuration was found with the EUT in the H positioning. The data reported in the table above was measured in this test setup.

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Band 41 Radiated Spurious Measurements (continued)

§2.1053 §27.53(m)

Field Strength of SPURIOUS Radiation

OPERATING FREQUENCY: 2685.00 MHz
 MEASURED OUTPUT POWER: 15.39 dBm = 0.035 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 10 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 28.39 dBc

FREQUENCY (MHz)	LEVEL @ ANTENNA TERMINALS (dBm)	SUBSTITUTE ANTENNA GAIN (dBi)	SPURIOUS EMISSION LEVEL (dBm)	POL (H/V)	(dBc)
5370.00	-35.16	10.96	-24.21	H	39.60
8055.00	-32.18	11.30	-20.88	H	36.27
10740.00	-72.61	12.50	-60.11	H	75.50
13425.00	-39.38	13.14	-26.24	H	41.63

Table 6-5. Radiated Spurious Data

NOTES:

1. This device was tested under all bandwidths, and RB configurations, and modulations. This device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported in the table above.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The "H" positioning is defined with the EUT lying flat on the test surface, the "H2" positioning is defined with the EUT standing up on its side, and the "V" positioning is defined with the EUT standing upright. The worst case test configuration was found with the EUT in the H positioning. The data reported in the table above was measured in this test setup.

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6.4 Band 41 Frequency Stability Measurements

\$2.1055 \$27.5(i) \$27.54

OPERATING FREQUENCY: 2,535,000,000 Hz

CHANNEL: 2655

REFERENCE VOLTAGE: 3.8 VDC

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.80	+ 20 (Ref)	2,535,000,000	0	0.0000000
100 %		- 30	2,534,999,996	-4	-0.0000002
100 %		- 20	2,534,999,983	-17	-0.0000007
100 %		- 10	2,534,999,985	-15	-0.0000006
100 %		0	2,534,999,996	-4	-0.0000002
100 %		+ 10	2,534,999,983	-17	-0.0000007
100 %		+ 20	2,534,999,989	-11	-0.0000004
100 %		+ 30	2,534,999,983	-17	-0.0000007
100 %		+ 40	2,534,999,996	-4	-0.0000002
100 %		+ 50	2,534,999,980	-20	-0.0000008
115 %	4.37	+ 20	2,534,999,980	-20	-0.0000008
BATT. ENDPOINT	3.40	+ 20	2,534,999,992	-8	-0.0000003

Table 6-6. Frequency Stability Data (Band 7)

Note:

Based on the results of the frequency stability test at the center channel the frequency deviation results measured are very small. As such it is determined that the channels at the band edge would remain in-band when the maximum measured frequency deviation noted during the frequency stability tests is applied. Therefore the device is determined to remain operating in band over the temperature and voltage range as tested.

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Band 41 Frequency Stability Measurements (Cont'd)

§2.1055 §27.5(i) §27.54

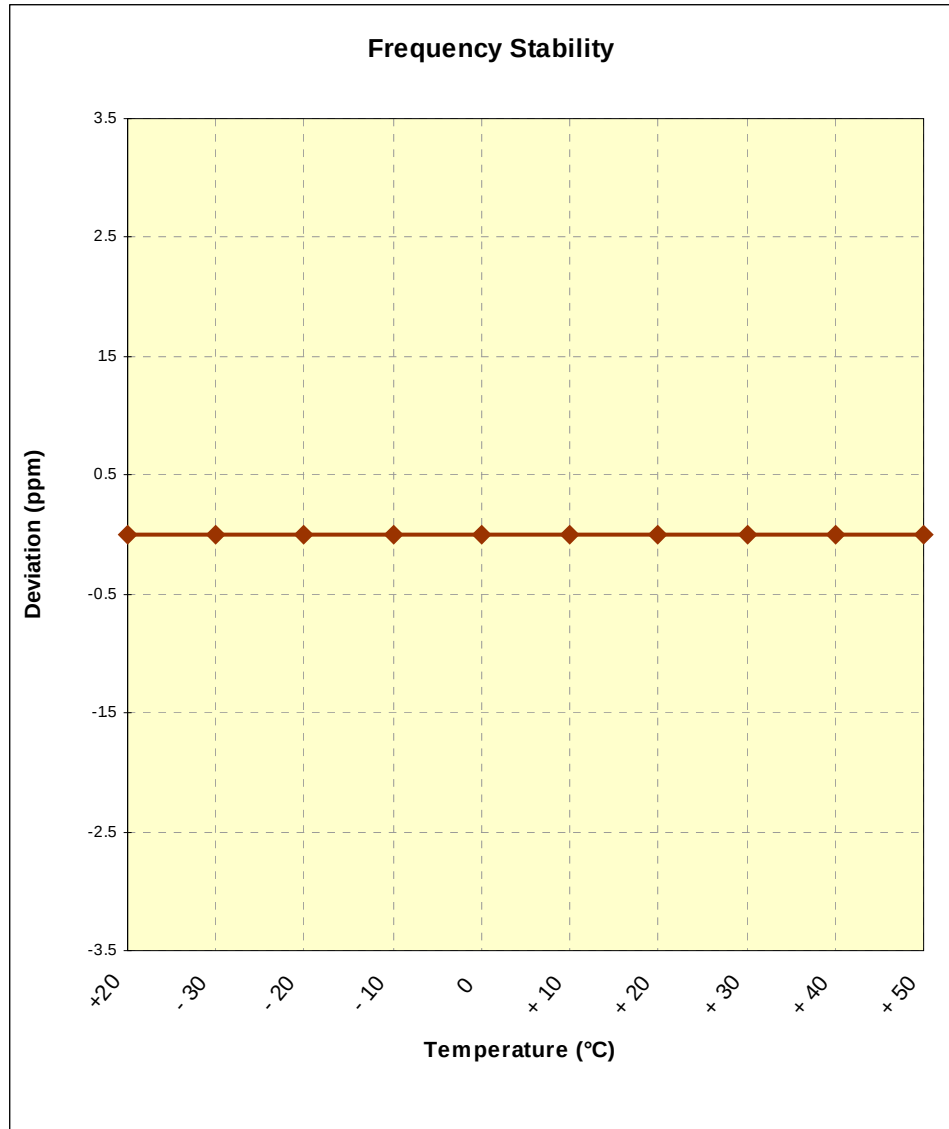
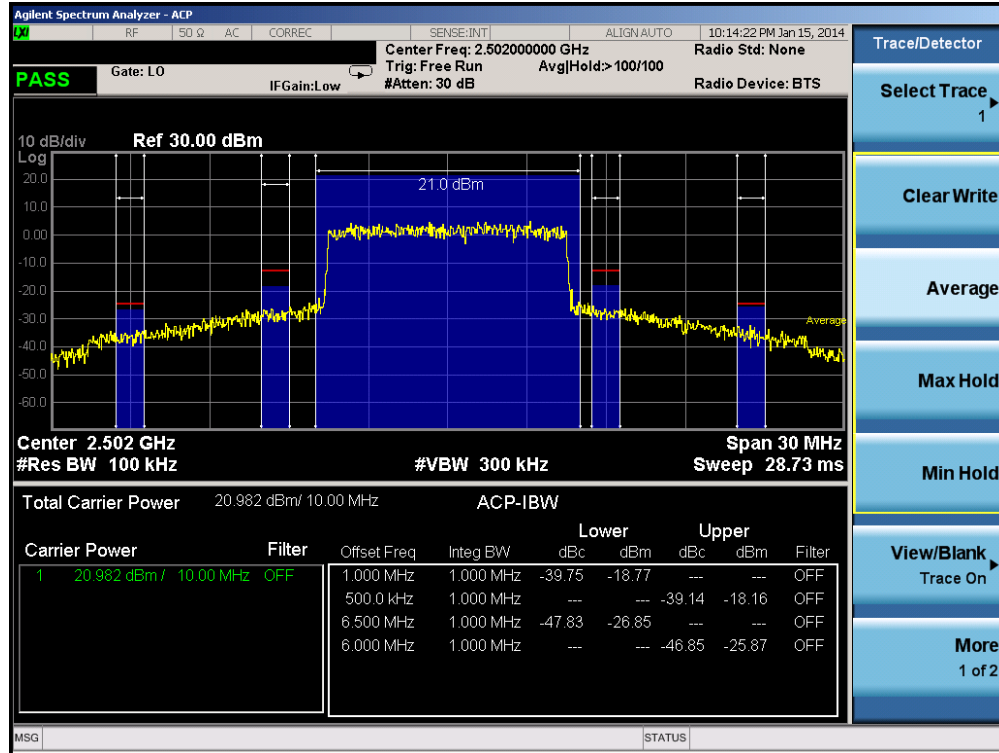


Figure 6-1. Frequency Stability Graph (Band 7)

FCC ID: A3LGTI9507V		FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
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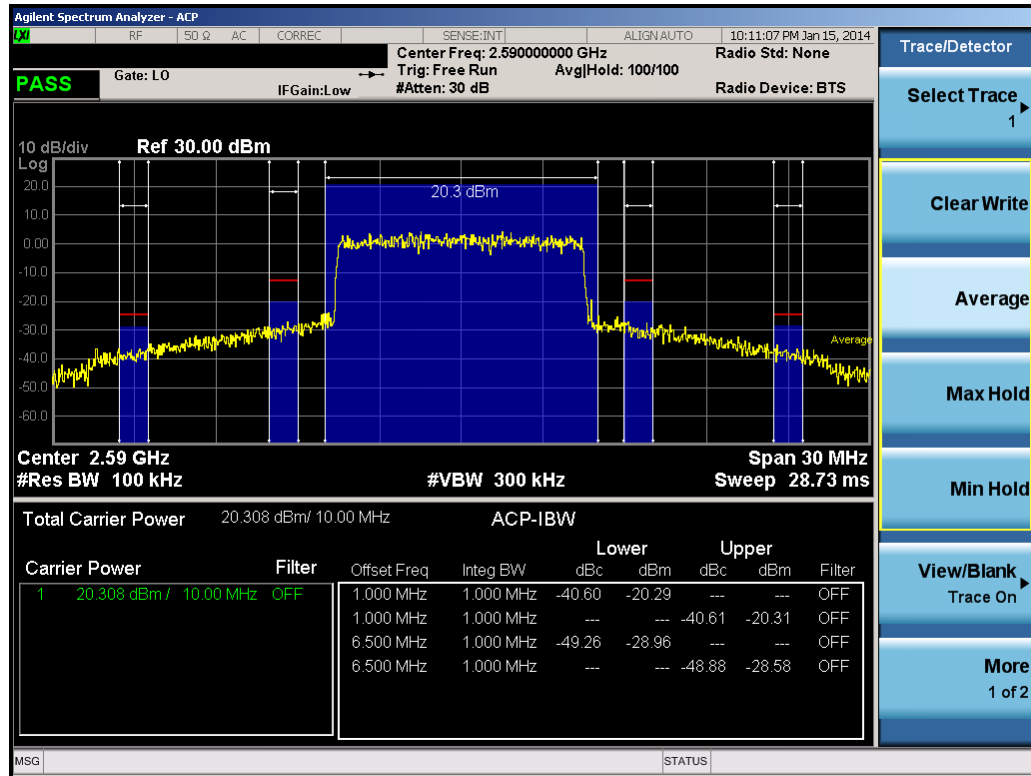
7.0 BAND 7 PLOTS OF EMISSIONS

Note: All bandwidths, RB configurations, and modulations were investigated. The worst case test results are reported below.

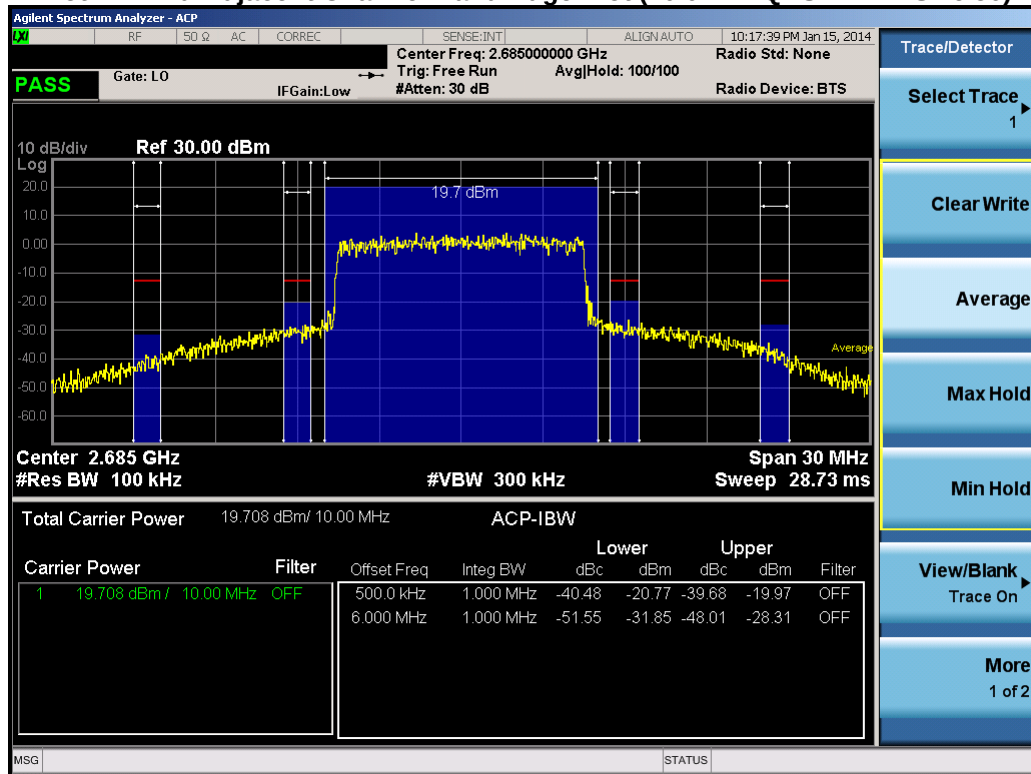


Plot 7-1. Low Adjacent Channel Band Edge Plot (10.0MHz QPSK – RB Size 50)

FCC ID: A3LGTI9507V	FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)			Reviewed by: Quality Manager
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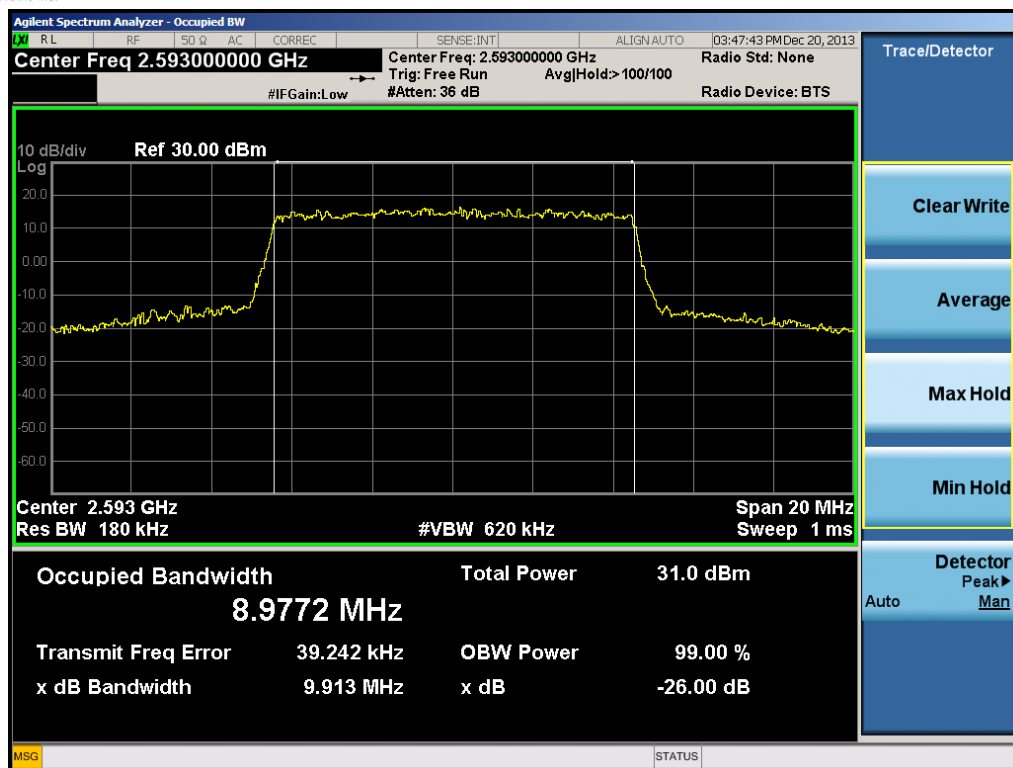


Plot 7-2. Mid Adjacent Channel Band Edge Plot (10.0MHz QPSK – RB Size 50)

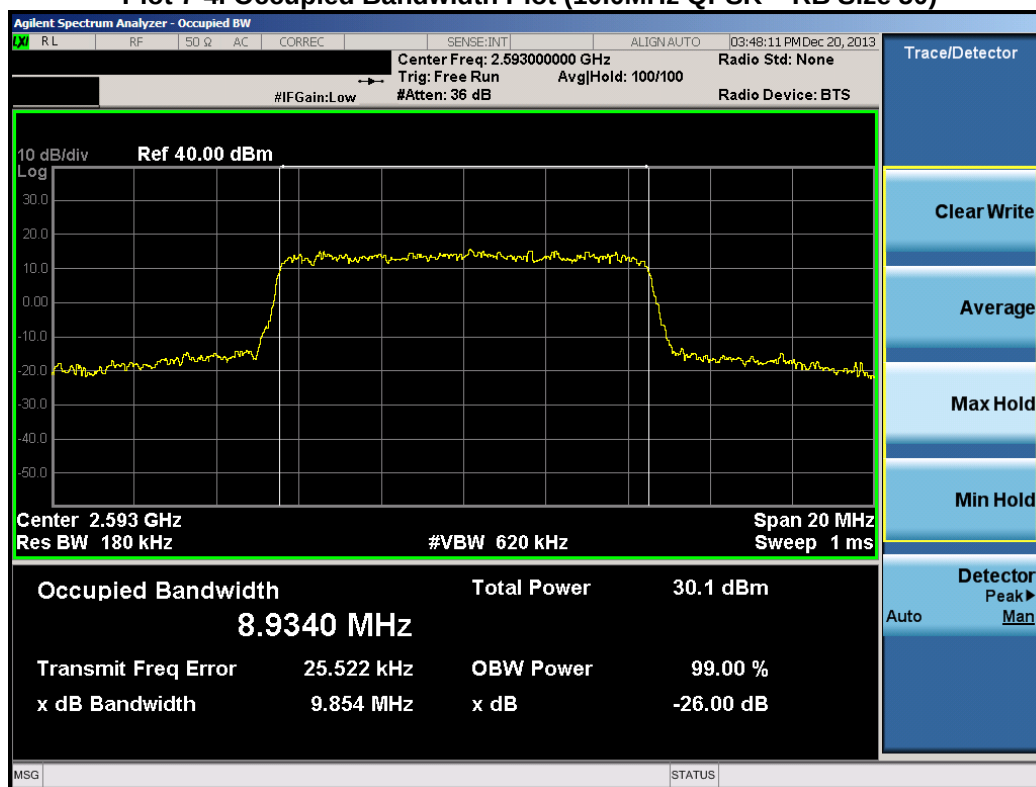


Plot 7-3. High Adjacent Channel Band Edge Plot (10.0MHz QPSK – RB Size 50)

FCC ID: A3LGTI9507V	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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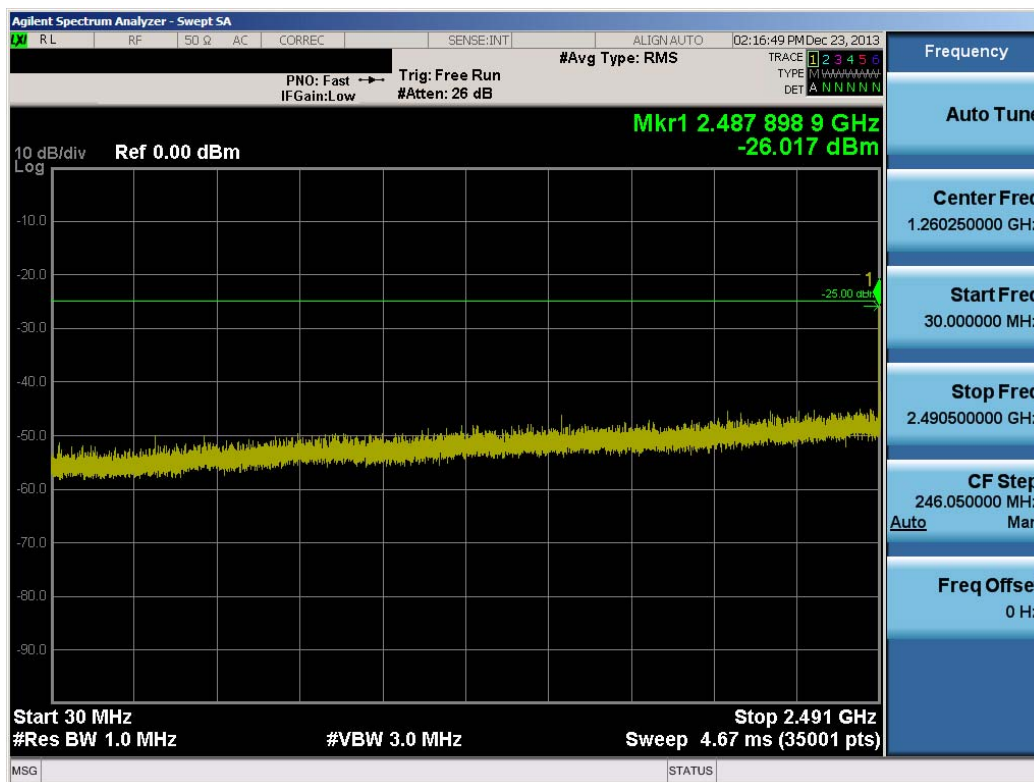


Plot 7-4. Occupied Bandwidth Plot (10.0MHz QPSK – RB Size 50)

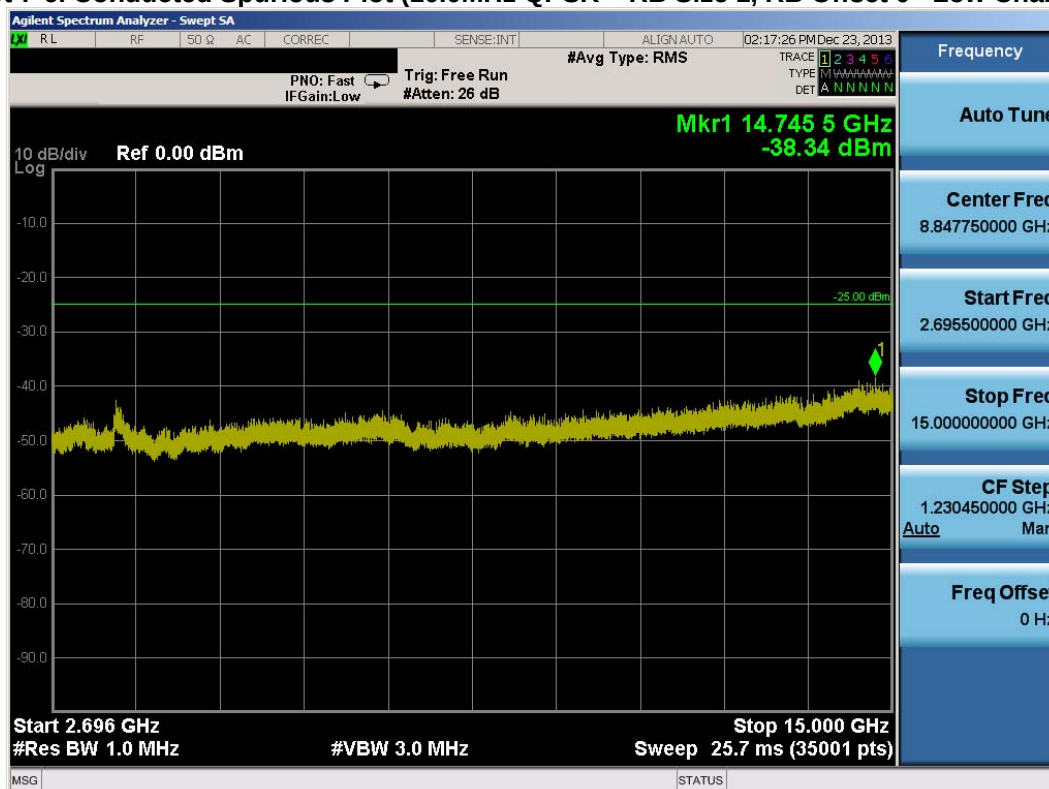


Plot 7-5. Occupied Bandwidth Plot (10.0MHz 16-QAM – RB Size 50)

FCC ID: A3LGT19507V	FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
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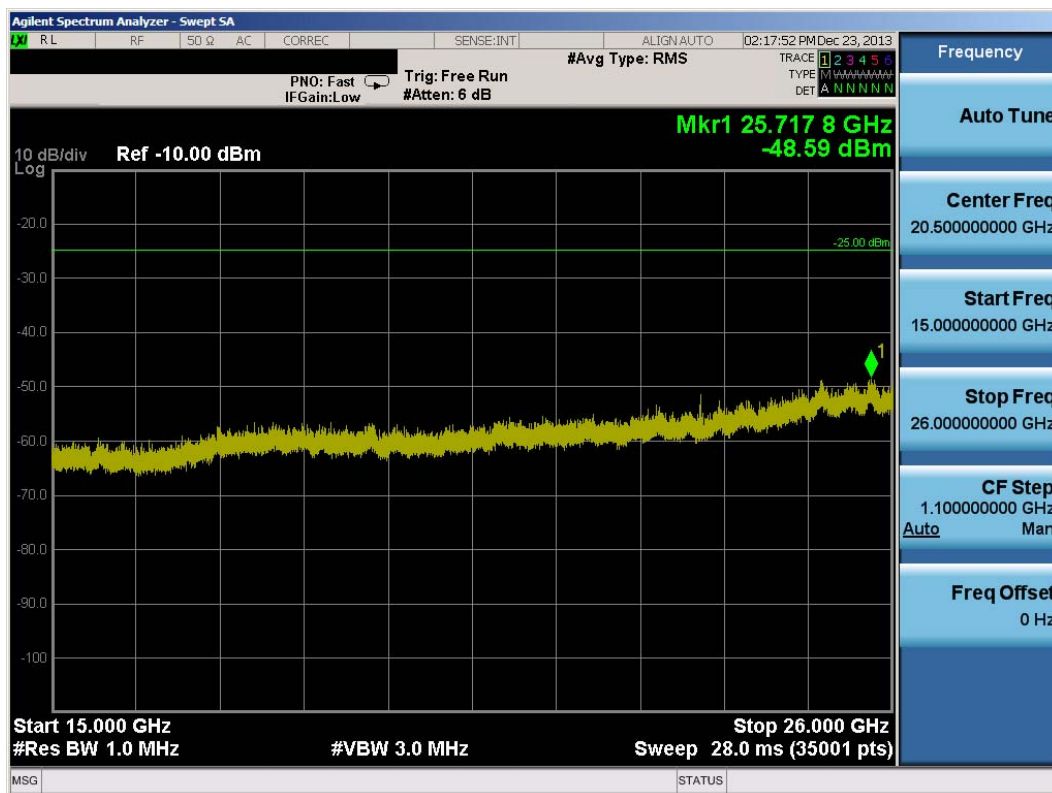


Plot 7-6. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0– Low Channel)

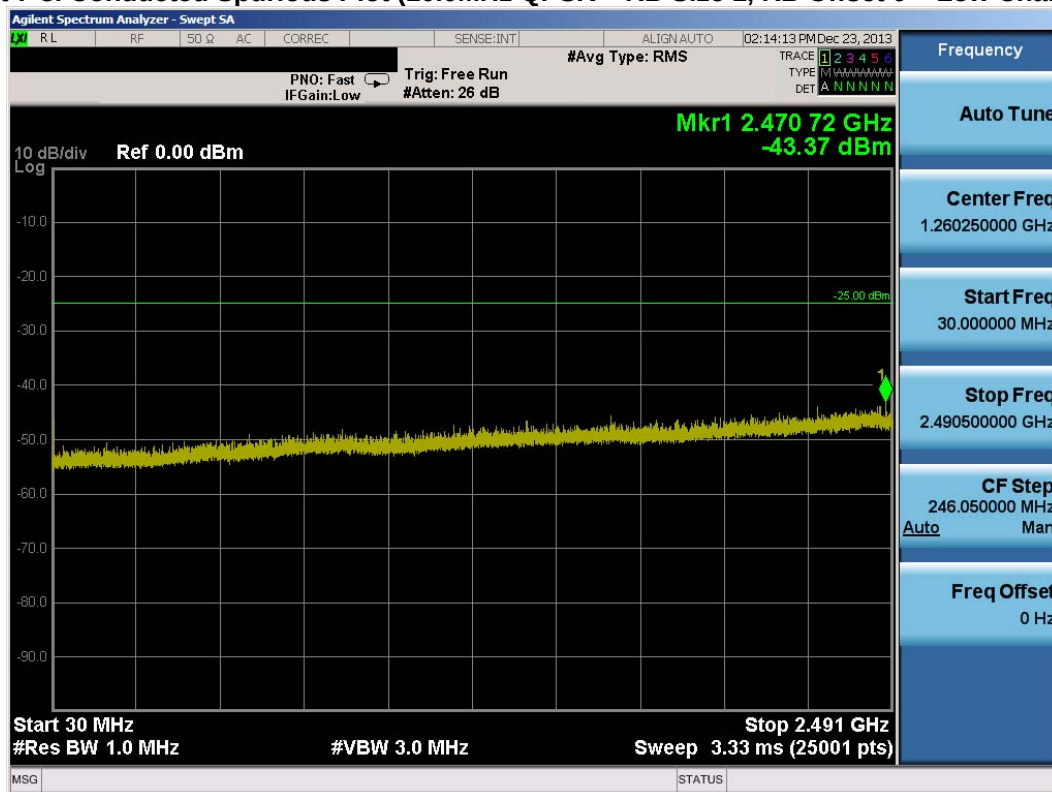


Plot 7-7. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

FCC ID: A3LGT19507V	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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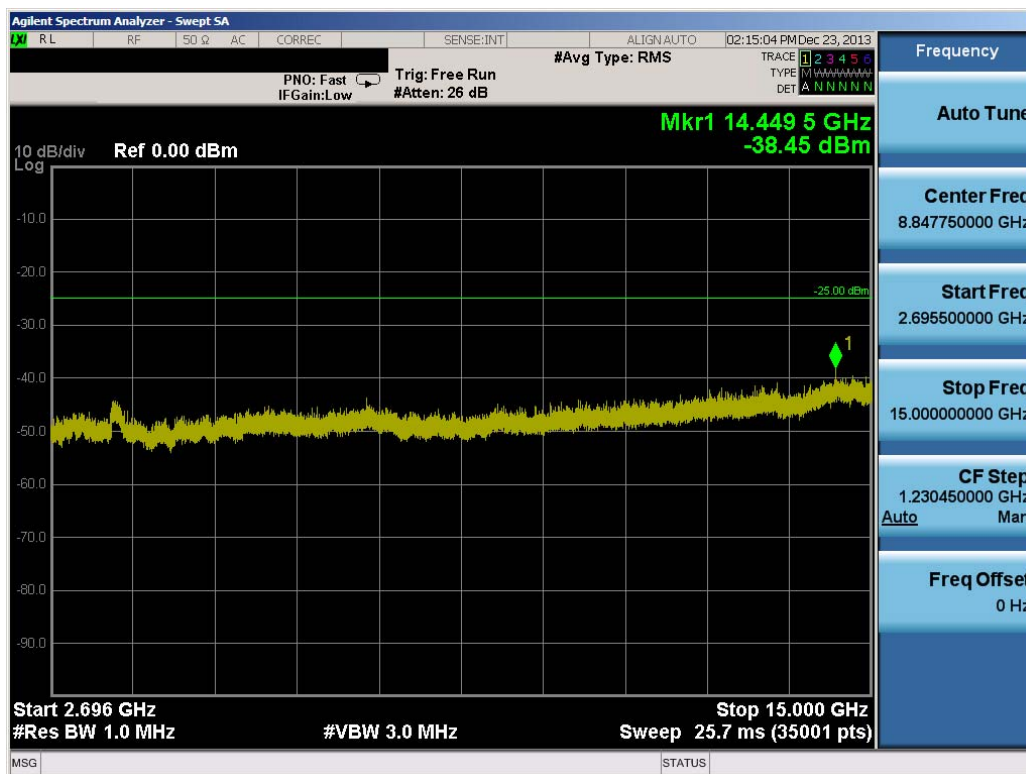


Plot 7-8. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

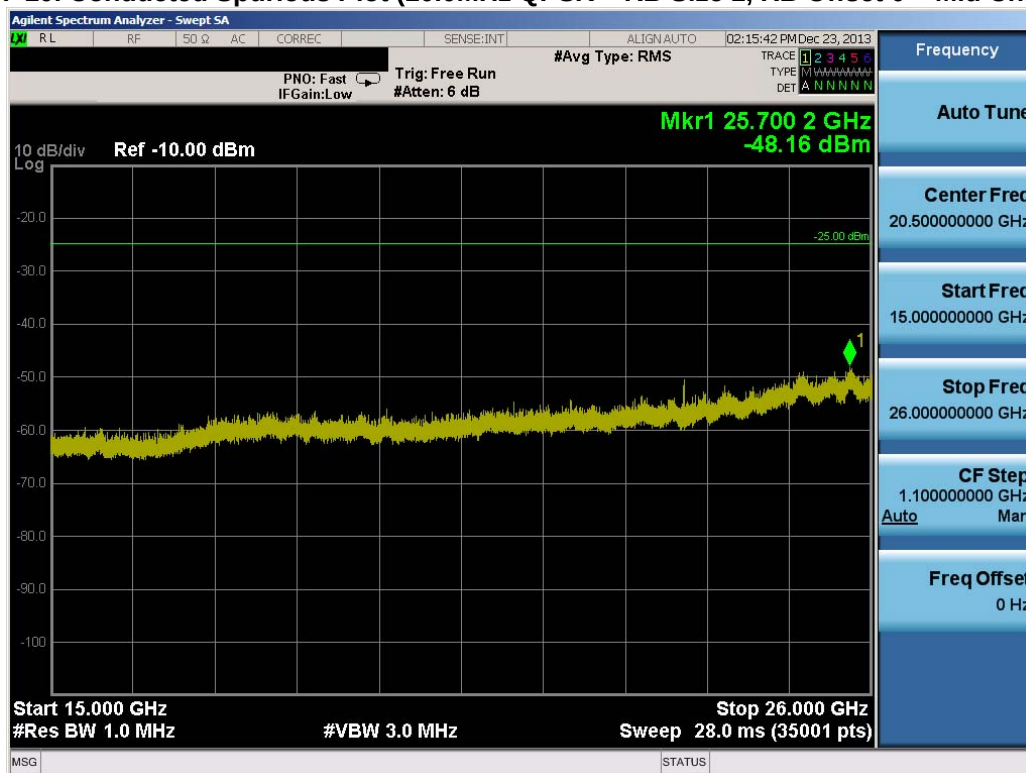


Plot 7-9. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LGTI9507V	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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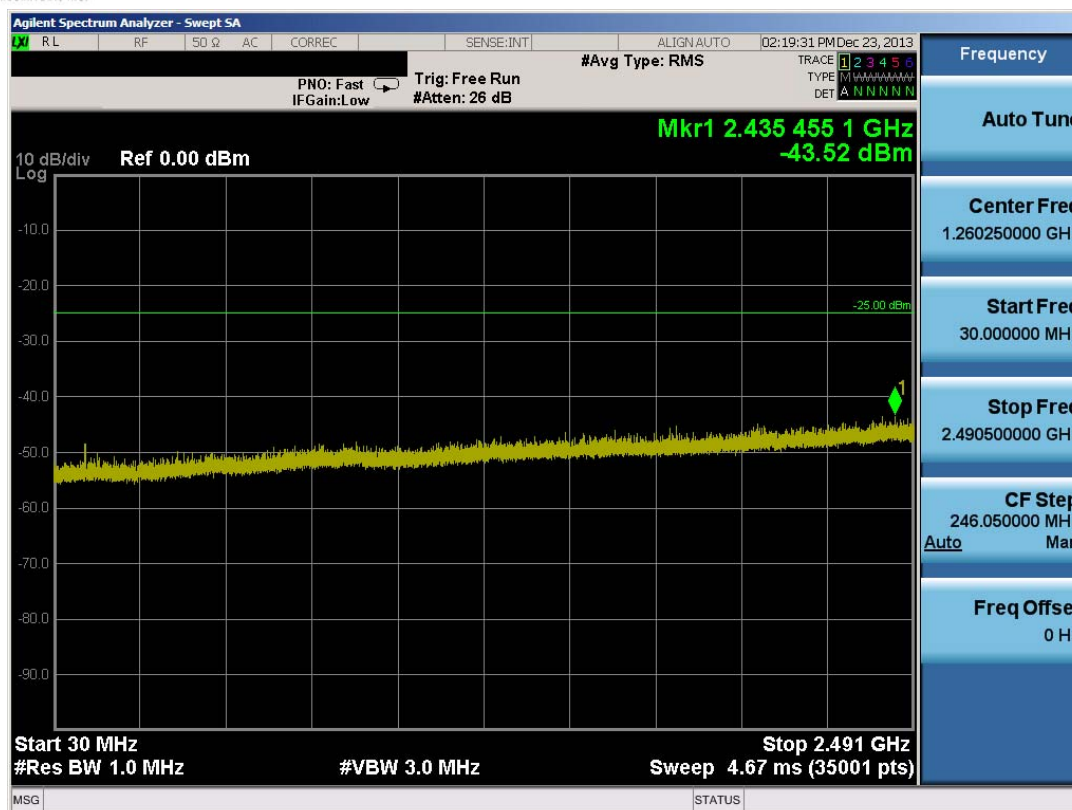


Plot 7-10. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

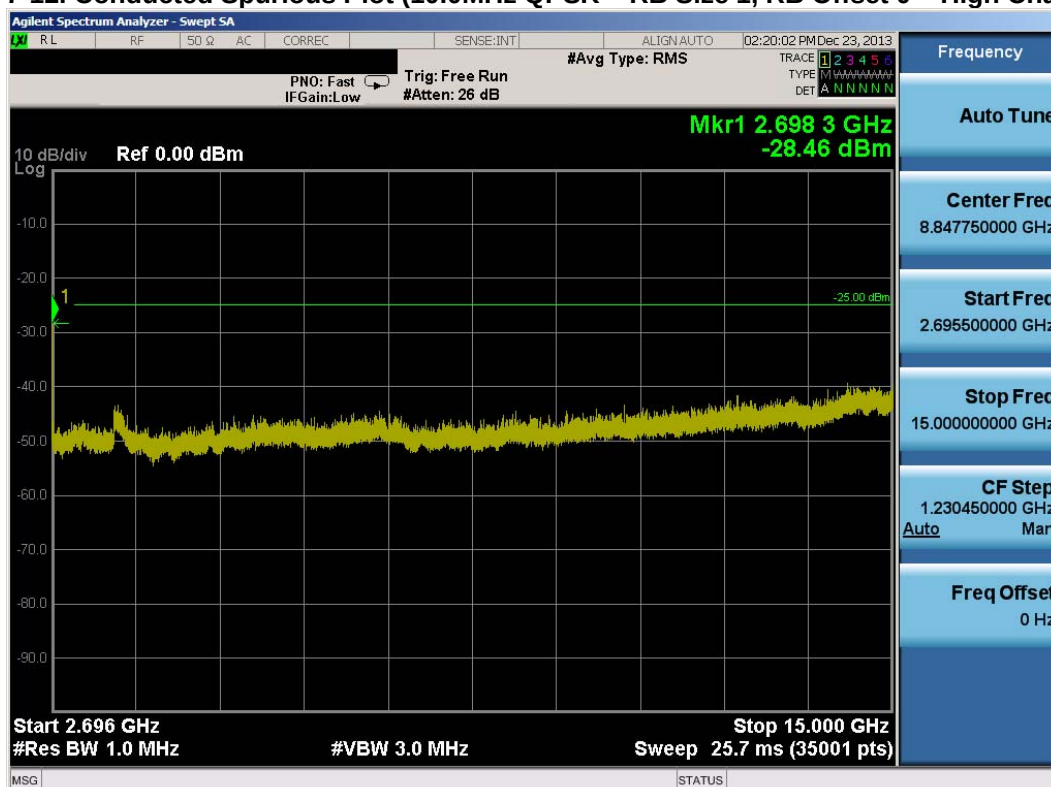


Plot 7-11. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LGTI9507V	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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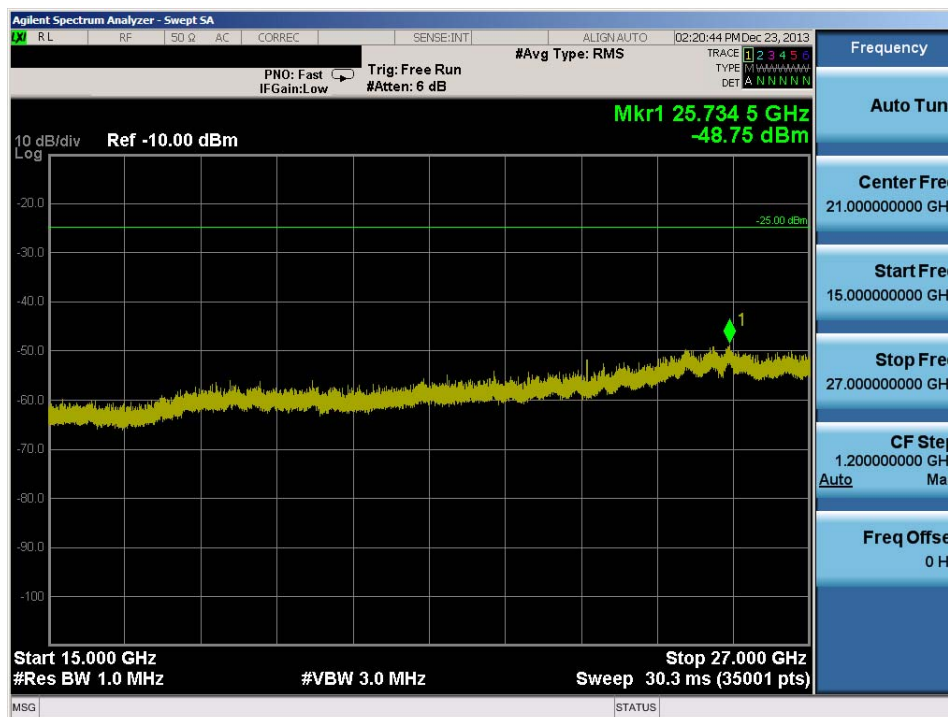


Plot 7-12. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

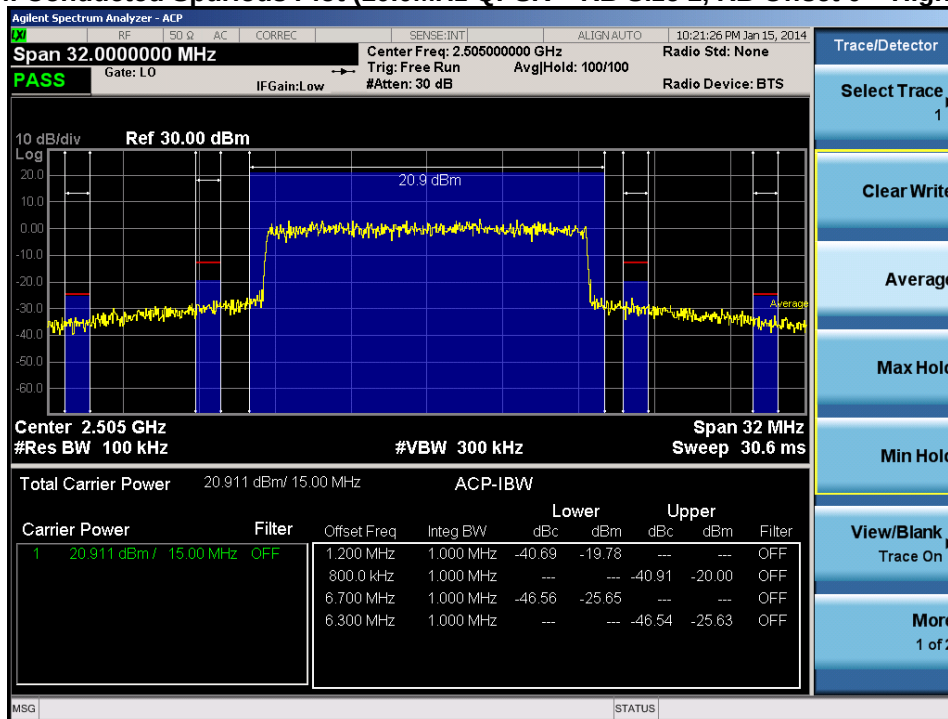


Plot 7-13. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LGT19507V	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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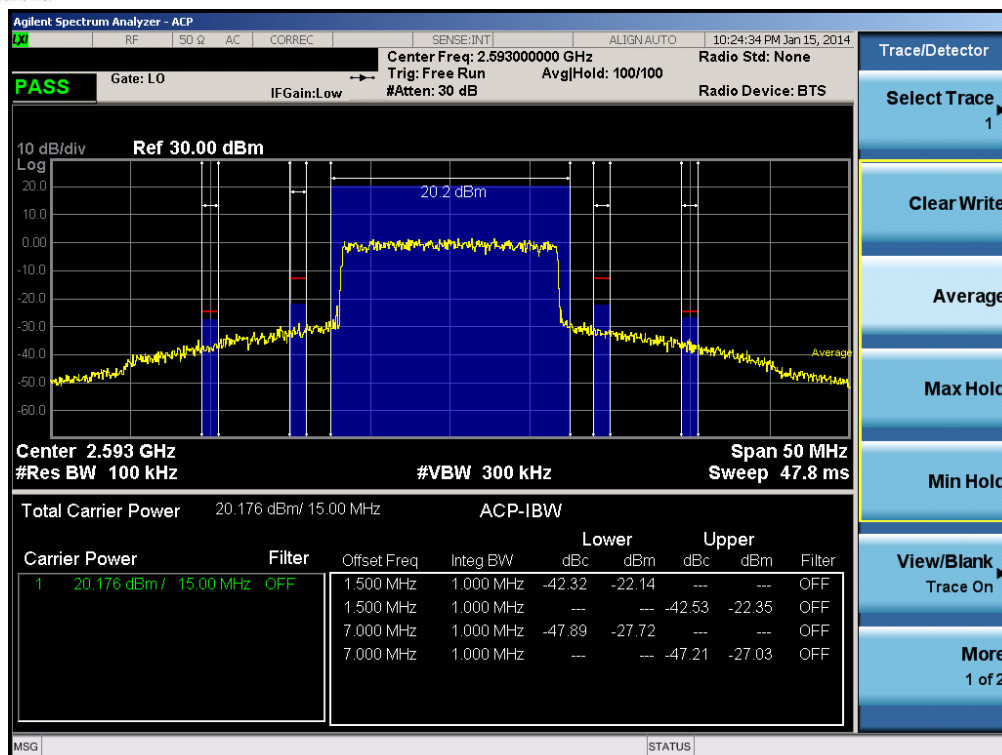


Plot 7-14. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

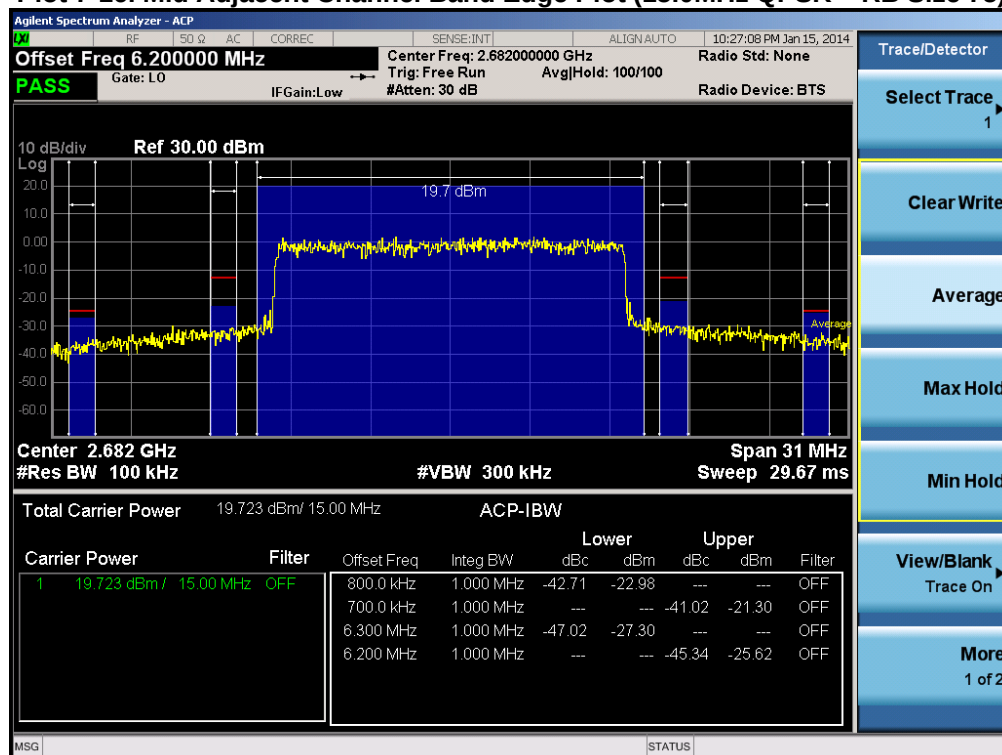


Plot 7-15. Low Adjacent Channel Band Edge Plot (15.0MHz QPSK – RB Size 75)

FCC ID: A3LGTI9507V	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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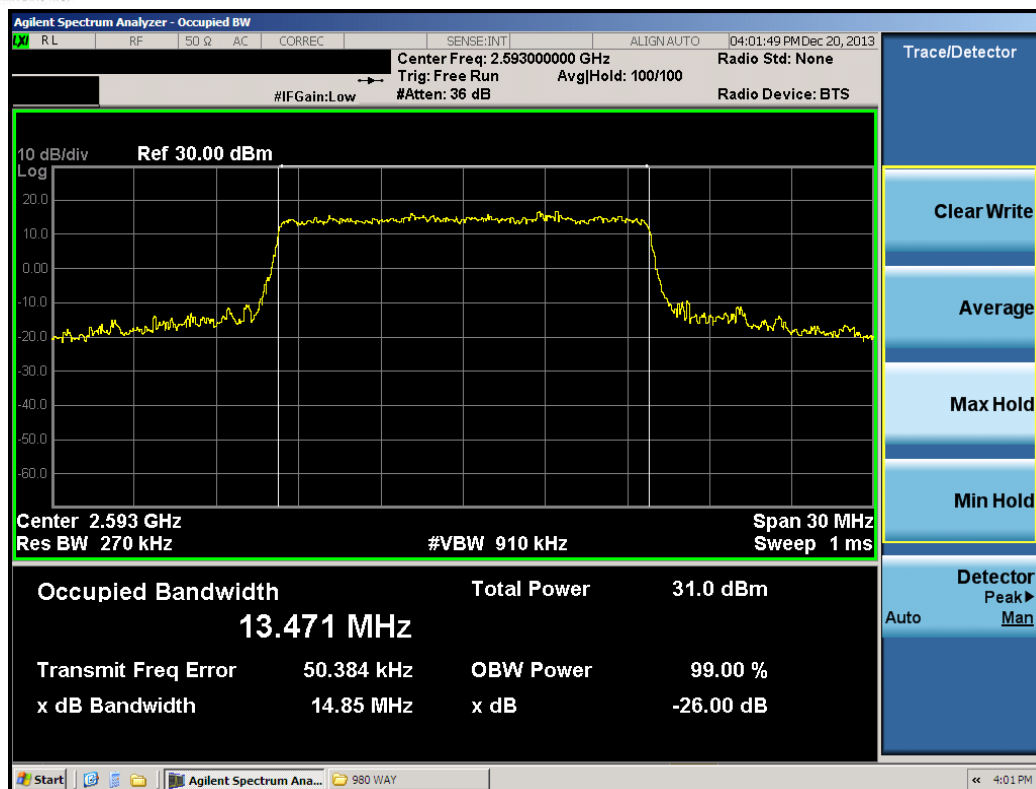


Plot 7-16. Mid Adjacent Channel Band Edge Plot (15.0MHz QPSK – RB Size 75)

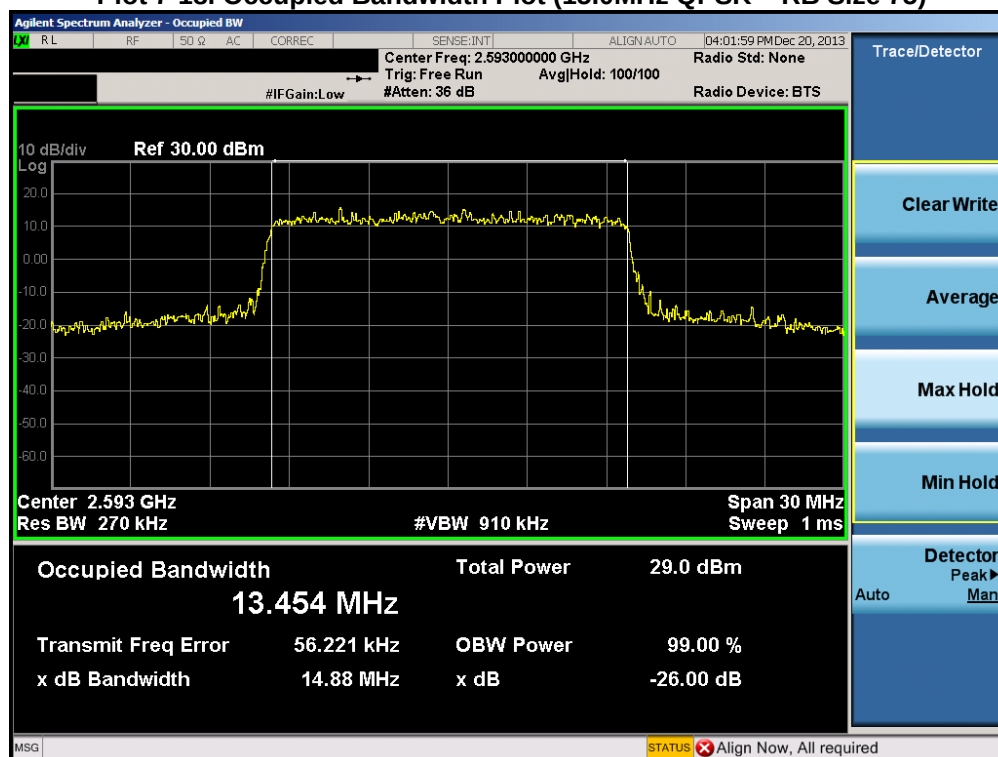


Plot 7-17. High Adjacent Channel Band Edge Plot (15.0MHz QPSK – RB Size 75)

FCC ID: A3LGTI9507V	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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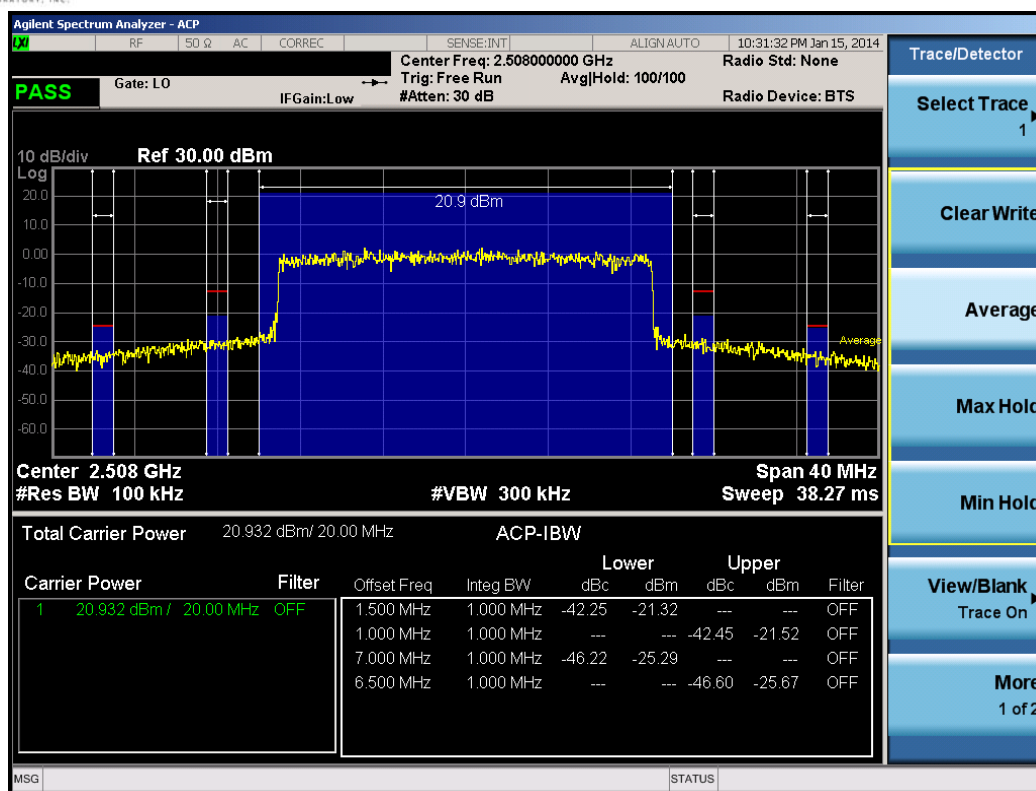


Plot 7-18. Occupied Bandwidth Plot (15.0MHz QPSK – RB Size 75)

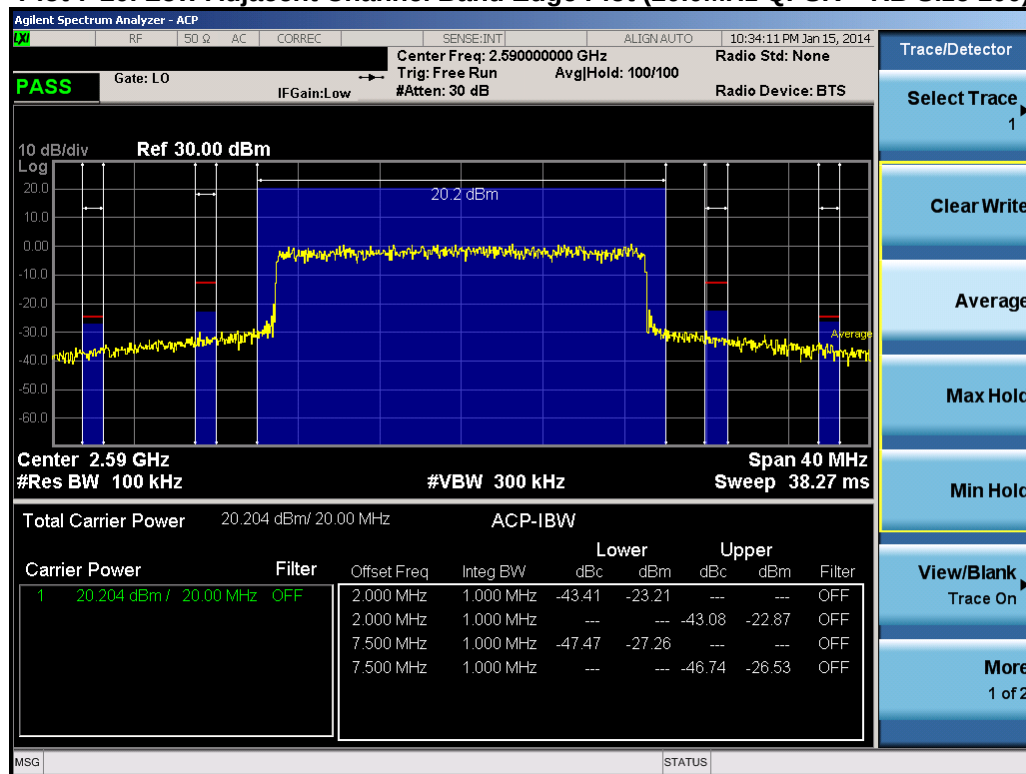


Plot 7-19. Occupied Bandwidth Plot (15.0MHz 16-QAM – RB Size 75)

FCC ID: A3LGTI9507V	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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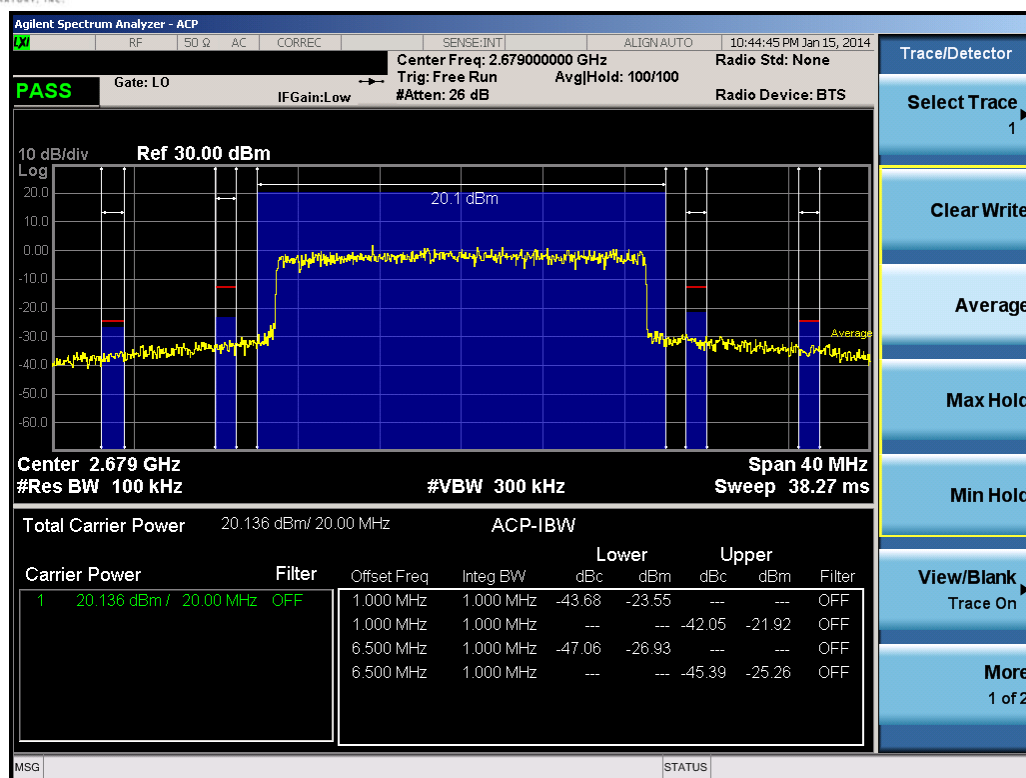


Plot 7-20. Low Adjacent Channel Band Edge Plot (20.0MHz QPSK – RB Size 100)

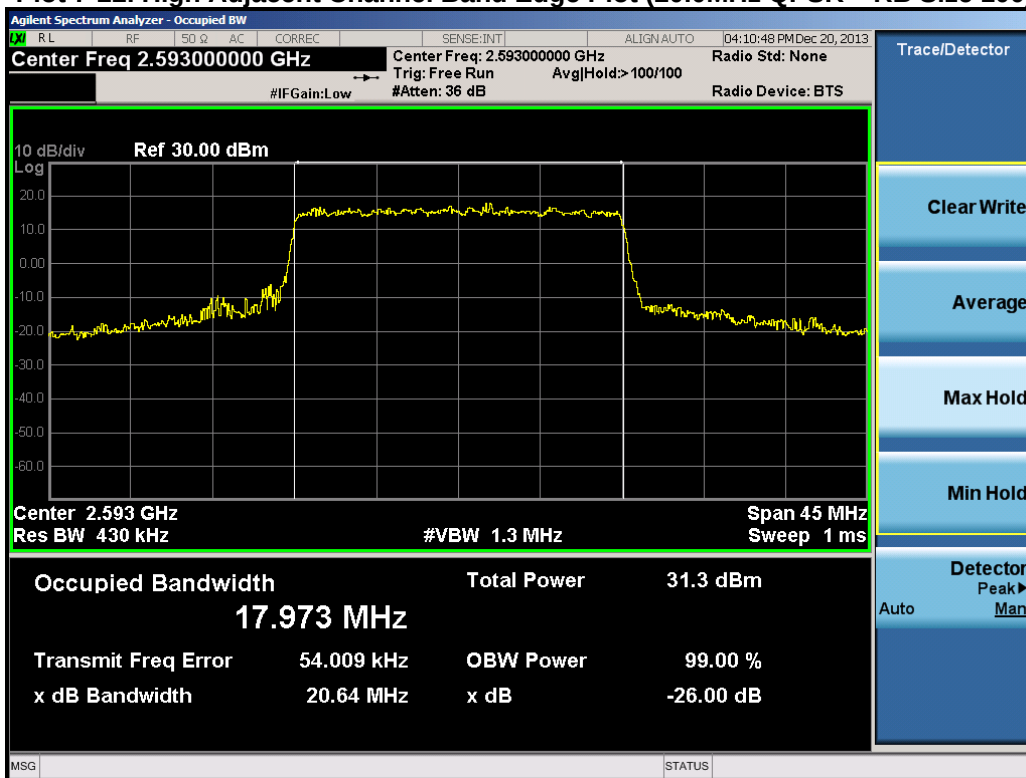


Plot 7-21. Mid Adjacent Channel Band Edge Plot (20.0MHz QPSK – RB Size 100)

FCC ID: A3LGTI9507V	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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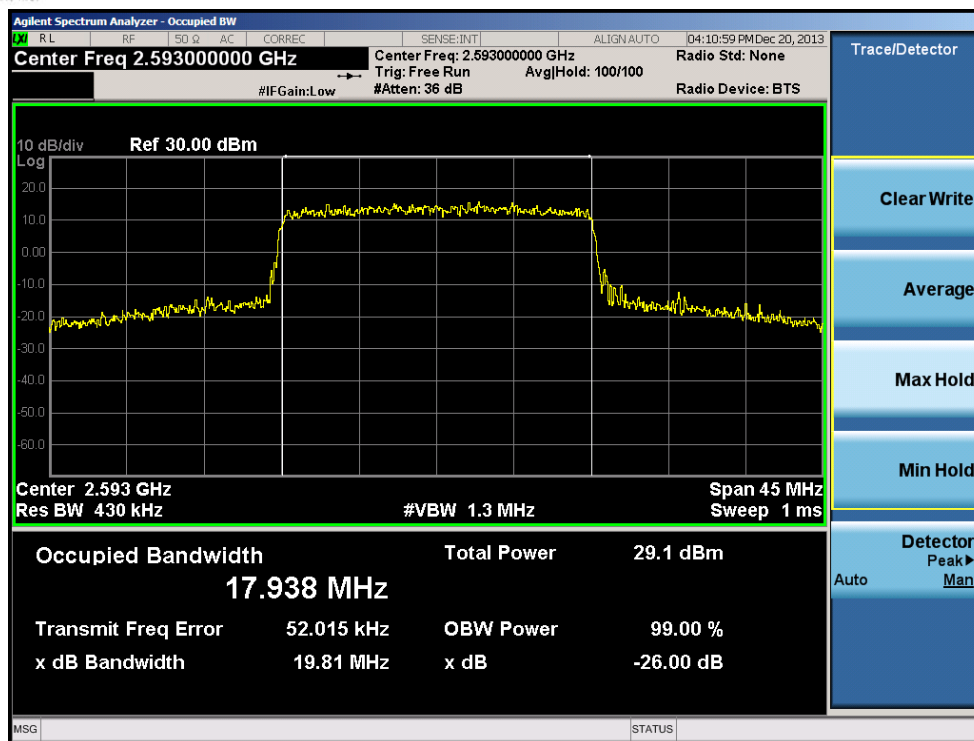


Plot 7-22. High Adjacent Channel Band Edge Plot (20.0MHz QPSK – RB Size 100)



Plot 7-23. Occupied Bandwidth Plot (20.0MHz QPSK – RB Size 100)

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Plot 7-24. Occupied Bandwidth Plot (20.0MHz 16QAM – RB Size 100)

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8.0 CONCLUSION

The data collected relate only to the item(s) tested and show that the **Samsung Portable Handset FCC ID: A3LGTI9507V** complies with all the requirements of Parts 2, 27 of the FCC rules for LTE operation only and RSS-199 of the Industry Canada rules.

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